

Electronic Information Disclosure Statement

METHODS FOR THE PREPARATION POLY(ETHERIMIDE)S

Application: *10/065197*

10/065197

Confirmation: 8148

Applicant(s): Roy Odle

Docket
Number: 08CU5767-1

Group Art

Unit:

Examiner:

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US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

Init	Citation No.	Patent Number	Date	Bar Code	Patentee	Class	Subclass
PH	P01	4827000	1989-05-02	*4827000*	Schwartz		
PH	P02	4864034	1989-09-05	*4864034*	Cella, et al.		
PH	P03	4868316	1989-09-19	*4868316*	Schwartz, Jr.		
PH	P04	4902809	1990-02-20	*4902809*	Groeneweg, et al.		
PH	P05	4921970	1990-05-01	*4921970*	Odle		

Name: P. Hegelmeier

Date: 12/2004

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P07	4962206	1990-10-09	*4962206*	Cocoman, et al.
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Name: P. Hightower

Date: 11/2004

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PAGE 18/19 * RCVD AT 9/23/2004 4:08:01 PM [Eastern Daylight Time] * SVR:USPTO-EFEXR-1/2 * DNIB:8729308 * CSID: * DURATION (mm-ss):06-56

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duplicate citation

Signature

Examiner Name	Date
<i>P. Hegstuen</i>	<i>12/2004</i>



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Note: Applicant is not required to submit a paper copy of cited US Patent Documents

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1	P03	2764597	1956-09-25	000000000000000000	Barney		
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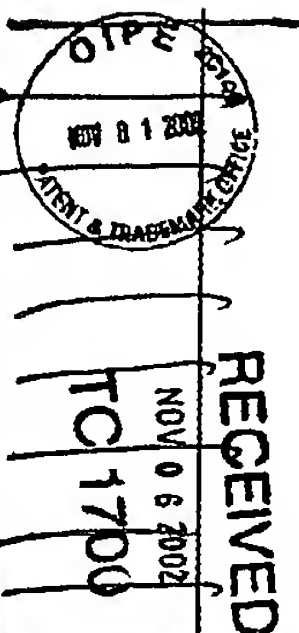
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Signature: P. Hightower

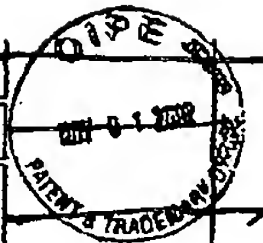
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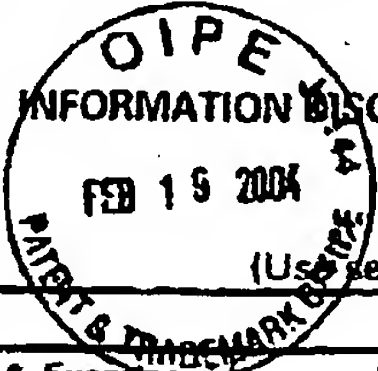


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P. Hightower

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Examiner Name	Date 9/29/03
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		PTO-1449		Attorney's Docket Number 08CU5767-1		Serial Number 10/065,197								
		Name of Applicant Guggenheim, et al												
		Filing Date September 25, 2002		Group 1711										
LIST OF ITEMS (Use several sheets if necessary)														
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Examiner Initials	Document Number							Date	Name	Class	Subclass	Filing Date if Appropriate		
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	AB	6	2	3	5	8	6	6	05/22/2001	Carrington				
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PH	AC	3	8	0	3	0	8	5	04/09/1974	Kochanowski	528	26	—	
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PH	AM	EP 1 059 291 A							12/13/2002	World				
	AN													
	AO													
OTHER INFORMATION (Including Author, Title, Date, Pertinent)														
	AP													
	AQ													
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EXAMINER <i>P. Hightower</i>									DATE CONSIDERED <i>4/2004</i>					
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